Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/001,712	TAKATORI ET AL.		
Examiner	Art Unit		
Sam K. Ahn	2637		

SEARCHED					
Class	Subclass	Date	Examiner		
375	287,360,371	6/19	ar		
714	700,709	8 loq	a		
			·		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
that keyword search inventor search class/sub earch citation search	8/04	ar		